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CIL

EMU CRITICAL ITEMS LIST 5/30/2002 SUPERSEDES 12/24/1991

EMO CRITICAL TIEM	2 1121	5/30/2002 SUPERSEDES 12/24/1991			Date: 4/24/2002
NAME P/N QTY	CRIT	FAILURE MODE & CAUSES	FAILURE EFFECT	RATIONALE FOR ACCEPTANCE	
		<u> 174FM02</u> — — —			
REAL TIME DATA SYSTEM, ITEM 174	2/1RB	Short circuit (within box	END ITEM: Additional	A. Design - All internal wires are Teflon insulated (M22759/1	
SV791230-2 (1)		after current limiting resistor).	current draw (0.64 amps) from EMU battery during EVA.	a minimum to reduce the possibility of being pinc unit. The electronic circuitry and components are RTV3140, MIL-A-46146) which prevents shorts due t with foreign objects and prevents shorts due to c Electrical connectors are environmentally sealed	conformal coated (Dow Corning o direct electrical contact ontamination or moisture.
		Electrical short in the	GFE INTERFACE:	humidity and contamination.	
		wiring or electronic	Loss of output from RTDS.	B. Test - Component Acceptance Test -	
		component.	Additional current draw is not sufficient to	Testing includes functional, insulation resistanc would detect the noted failure. Proper operation during PLSS PDA electrical tests.	
			cause DCM	PDA Test -	
			shutdown. All other systems	Continuity and functional per SEMU-60-010, Para.	7 and 8.
			would operate	Certification Test -	
			normally.	Certified for a useful life of 20 years (Ref. EMU	M1-0244).
			MISSION:	C. Inspection -	
			EVA mission shortened due to additional current draw and premature depletion of	Each circuit board, the wiring, and connectors ar contamination prior to being placed into finished internally and externally during assembly and ext and contamination.	stores. The RTDS is inspected
			battery.	D. Failure History -	
			CREW/VEHICLE: None.	None.	
			TIME TO EFFECT	E. Ground Turnaround - Tested for non-EET processing per FEMU-R-001, Rea FEMU-R-001. Para. 8.2, EMU Pre-flight KSC Checkou	
			/ACTIONS:		t for EET processing.
			Minutes.	F. Operational Use - Crew Response -	
			TIME AVAILABLE: Minutes.	PreEVA/PostEVA: Trouble shoot problem. If no succ available. Otherwise, continue EVA prep. EVA: For single failure, no constraints.	ess, consider third EMU if
			MINE DECLIDES	Training - Standard training covers this failure	
			TIME REQUIRED: Minutes.	Operational Considerations - EVA checklist proced and system operational status prior to EVA. Fligh when minimum primary consumables remain.	
			REDUNDANCY		

REDUNDANCY SCREENS: A-PASS B-FAIL C-PASS

EXTRAVEHICULAR MOBILITY UNIT

SYSTEMS SAFETY REVIEW PANEL REVIEW

FOR THE

I-174 REAL TIME DATA SYSTEM

CRITICAL ITEM LIST (CIL)

EMU CONTRACT NO. NAS 9-97150

Prepared by:

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